Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/550,192	TANG ET AL.	
Examiner	Art Unit	
Frie B. Kine	2402	

	SEARCHED				
Class	Subclass	Date	Examiner		
717	107, 108, 174	10/14/2005	EBK		
705	79	10/14/2005	EBK		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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DATE	
DATE	EXMR
10/14/2005	EBK
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